Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	nt under	
10/724,374	BAE ET AL.		
Examiner	Art Unit		
Rin A Lee	1713		

SEARCHED				
Class	Subclass	Date	Examiner	
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524	567	0617600	SM_	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
524	487	06277200	50	
524	567	0.4700	2	,
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Jul Seen	OS 17-13	S/		